

ATA6564

High-Speed CAN Transceiver with Silent Mode - CAN FD Ready

Features

- Fully ISO 11898-2, ISO 11898-2: 2016 and SAE J2962-2 Compliant
- CAN FD Ready
- · Communication Speed up to 5 Mbit/s
- Low Electromagnetic Emission (EME) and High Electromagnetic Immunity (EMI)
- Differential Receiver with Wide Common Mode Range
- · Compatible to 3.3V and 5V Microcontrollers
- Functional Behavior Predictable under all Supply Conditions
- Transceiver Disengages from the Bus When Not Powered-up
- RXD Recessive Clamping Detection
- High Electrostatic Discharge (ESD) Handling Capability on the Bus Pins
- Bus Pins Protected against Transients in Automotive Environments
- Transmit Data (TXD) Dominant Time-out Function
- Undervoltage Detection on VCC and VIO Pins
- CANH/CANL Short-circuit and Overtemperature
 Protected
- Fulfills the OEM *"Hardware Requirements for LIN, CAN and FlexRay Interfaces in Automotive Applications", Rev.* 1.3
- · Qualified According to AEC-Q100
- Two Ambient Temperature Grades:
 - ATA6564-GAQW1 and ATA6564-GBQW1 up to T_{amb} = +125°C
 - ATA6564-GAQW0 and ATA6564-GBQW0 up to T_{amb} = +150°C
- Packages: 8-pin SOIC, 8-pin VDFN with Wettable Flanks (Moisture Sensitivity Level 1)

Applications

Classical CAN and CAN FD networks in Automotive, Industrial, Aerospace, Medical and Consumer applications.

General Description

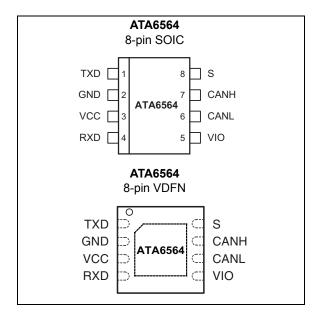
The ATA6564 is a high-speed CAN transceiver that provides an interface between a controller area network (CAN) protocol controller and the physical two-wire CAN bus. The transceiver is designed for high-speed (up to 5 Mbit/s) CAN applications in the automotive industry, providing differential transmit and receive capability to (a microcontroller with) a CAN protocol controller.

It offers improved electromagnetic compatibility (EMC) and electrostatic discharge (ESD) performance, as well as features such as:

- ideal passive behavior to the CAN bus when the supply voltage is off
- direct interfacing to microcontrollers with supply voltages from 3V to 5V

Two operating modes together with the dedicated fail-safe features make the ATA6564 an excellent choice for all types of high-speed CAN networks especially in nodes which do not require a Standby mode with wake-up capability via the bus.

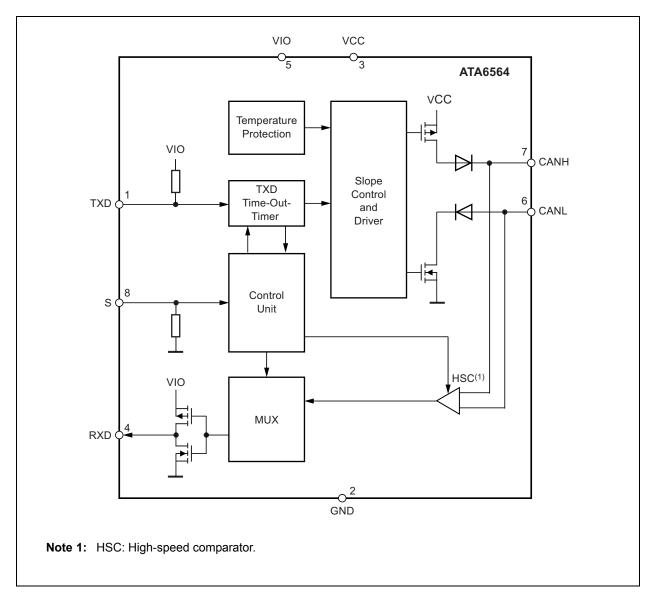
Package Types



Device	Grade 0	Grade 1	VDFN8	SOIC8	Description
ATA6564-GAQW0	x			х	Silent mode, VIO - pin for compatibility with 3,3V and 5V microcontroller
ATA6564-GBQW0	x		x		Silent mode, VIO - pin for compatibility with 3,3V and 5V microcontroller
ATA6564-GAQW1		x		х	Silent mode, VIO - pin for compatibility with 3,3V and 5V microcontroller
ATA6564-GBQW1		х	х		Silent mode, VIO - pin for compatibility with 3,3V and 5V microcontroller

TABLE 0-1: ATA6564 FAMILY MEMBERS

Functional Block Diagram



1.0 DEVICE OVERVIEW

The ATA6564 is a stand-alone high-speed CAN transceiver compliant with the ISO 11898-2, ISO 11898-2: 2016 and SAE J2962-2 CAN standards. It provides very low current consumption in Silent mode.

1.1 Operating Modes

The ATA6564 supports two operating modes: Silent and Normal. These modes can be selected via the S pin. See Figure 1-1 and Table 1-1 for a description of the operating modes.

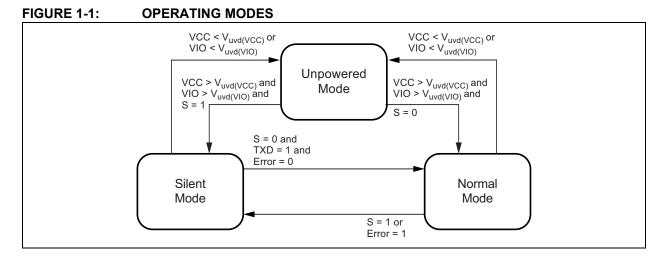


TABLE 1-1: OPERATING MODES

Mode	Inp	outs	Outputs		
Wode	S Pin TXD		CAN Driver	Pin RXD	
Unpowered	x ⁽²⁾	x ⁽²⁾	Recessive	Recessive	
Silent	HIGH	x ⁽²⁾	Recessive	Active ⁽¹⁾	
Normal	LOW	LOW	Dominant	LOW	
	LOW	HIGH	Recessive	HIGH	

Note 1: LOW if the CAN bus is dominant, HIGH if the CAN bus is recessive.

2: Irrelevant

1.1.1 NORMAL MODE

A low level on the S pin together with a high level on pin TXD selects the Normal mode. In this mode the transceiver is able to transmit and receive data via the CANH and CANL bus lines (see Section "Functional Block Diagram"). The output driver stage is active and drives data from the TXD input to the CAN bus. The high-speed comparator (HSC) converts the analog data on the bus lines into digital data which is output to pin RXD. The bus biasing is set to $V_{VCC}/2$ and the undervoltage monitoring of VCC is active.

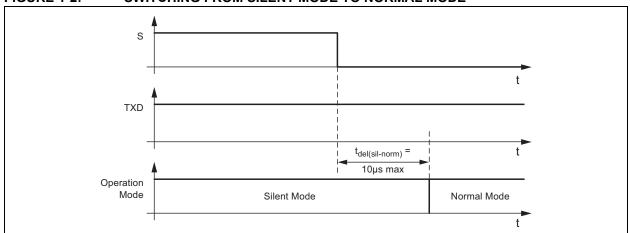
The slope of the output signals on the bus lines is controlled and optimized in a way that guarantees the lowest possible electromagnetic emission (EME).

To switch the device in normal operating mode, set the S pin to low and the TXD pin to high (see Table 1-1 and Figure 1-2). The S pin provides a pull-down resistor to GND, thus ensuring a defined level if the pin is open.

Please note that the device cannot enter Normal mode as long as TXD is at ground level.

ATA6564

FIGURE 1-2: SWITCHING FROM SILENT MODE TO NORMAL MODE



1.1.2 SILENT MODE

A high level on the S pin selects Silent mode. This receive-only mode can be used to test the connection of the bus medium. In Silent mode the ATA6564 can still receive data from the bus, but the transmitter is disabled and therefore no data can be sent to the CAN bus. The bus pins are released to recessive state. All other IC functions, including the high-speed comparator (HSC), continue to operate as they do in Normal mode. Silent mode can be used to prevent a faulty CAN controller from disrupting all network communications.

1.2 Fail-safe Features

1.2.1 TXD DOMINANT TIME-OUT FUNCTION

A TXD dominant time-out timer is started when the TXD pin is set to LOW. If the LOW state on the TXD pin persists for longer than $t_{to(dom)TXD}$, the transmitter is disabled, releasing the bus lines to recessive state. This function prevents a hardware and/or software application failure from driving the bus lines to a permanent dominant state (blocking all network communications). The TXD dominant time-out timer is reset when the TXD pin is set to high. If the low state on the TXD pin was longer than $t_{to(dom)TXD}$, then the TXD pin has to be set to high longer 4 µs in order to reset the TXD dominant time-out timer.

1.2.2 INTERNAL PULL-UP/PULL-DOWN STRUCTURE AT THE TXD AND S INPUT PINS

The TXD pin has an internal pull-up resistor to VIO and the S pin an internal pull-down resistor to GND. This ensures a safe, defined state in case one or all of these pins are left floating.

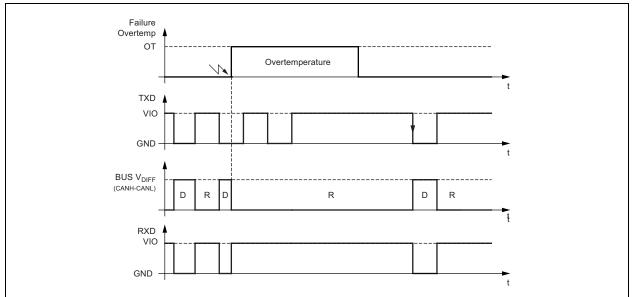
1.2.3 UNDERVOLTAGE DETECTION ON PINS VCC AND VIO

If V_{VCC} or V_{VIO} drop below their respective undervoltage detection levels ($V_{uvd(VCC)}$ and $V_{uvd(VIO)}$ (see Section, Electrical Characteristics), the transceiver switches off and disengages from the bus until V_{VCC} and V_{VIO} have recovered. The logic state of the S pin is ignored until the VCC voltage or the VIO voltage has recovered.

1.2.4 OVERTEMPERATURE PROTECTION

The output drivers are protected against overtemperature conditions. If the junction temperature exceeds the shutdown junction temperature, T_{Jsd} , the output drivers are disabled until the junction temperature drops below T_{Jsd} and pin TXD is at high level again. This ensures that output driver oscillations due to temperature drift are avoided.





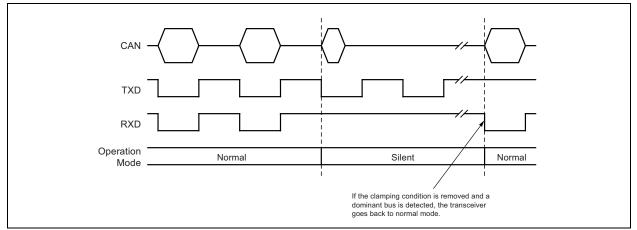
1.2.5 SHORT-CIRCUIT PROTECTION OF THE BUS PINS

The CANH and CANL bus outputs are short-circuit protected, either against GND or a positive supply voltage. A current-limiting circuit protects the transceiver against damage. If the device is heating up due to a continuous short on CANH or CANL, the internal overtemperature protection switches off the bus transmitter.

1.2.6 RXD RECESSIVE CLAMPING

This fail-safe feature prevents the controller from sending data on the bus if its RXD line is clamped to HIGH (e.g., recessive). That is, if the RXD pin cannot signalize a dominant bus condition because it is e.g, shorted to VCC, the transmitter within ATA6564 is disabled to avoid possible data collisions on the bus. In Normal and Silent mode, the device permanently compares the state of the high-speed comparator (HSC) with the state of the RXD pin. If the HSC indicates a dominant bus state for more than t_{RC_det} without the RXD pin doing the same, a recessive clamping situation is detected and the device is forced into Silent mode. This Fail-safe mode is released by either entering Unpowered mode or if the RXD pin is showing a dominant (e.g., LOW) level again.

FIGURE 1-4: RXD RECESSIVE CLAMPING DETECTION



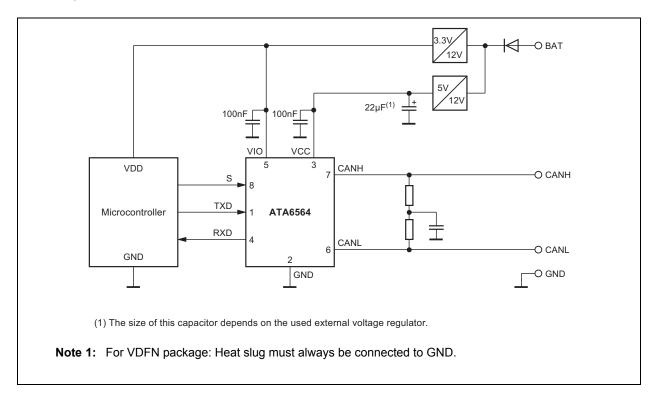
1.3 Pin Descriptions

The descriptions of the pins are listed in Table 1-2.

TABLE 1-2: PIN FUNCTION TABLE

Pin Number	Pin Name	Description			
1	TXD	Transmit data input			
2	GND	Ground supply			
3	VCC	Supply voltage			
4	RXD	Receive data output; reads out data from the bus lines			
5	VIO	Supply voltage for I/O level adapter			
6	CANL	Low-level CAN bus line			
7	CANH	High-level CAN bus line			
8	S	Silent mode control input			
9	EP ⁽¹⁾	Exposed Thermal Pad: Heat slug, internally connected to the GND pin.			
Note 1: Only for t	he VDFN packa	age.			

1.4 Typical Application



2.0 ELECTRICAL CHARACTERISTICS

2.1 Absolute Maximum Ratings^(†)

DC Voltage at CANH and CANL	–27V to +42V
Transient Voltage on CANH and CANL (ISO 7637 part 2)	–150V to +100V
Max. differential bus voltage	–5V to +18V
DC voltage on all other pins	–0.3V to +5.5V
ESD on CANH and CANL pins (IEC 61000-4-2)	±8 kV
ESD (HBM following STM 5.1 with 1.5 $k\Omega/100$ pF) (Pins CANH, CANL to GND)	±6 kV
Component Level ESD (HBM according to ANSI/ESD STM 5.1) JESD22-A114, AEC-Q 100 (002)	±4 kV
CDM ESD STM 5.3.1	±750V
ESD machine model AEC-Q100-RevF(003)	±200V
Virtual Junction Temperature	–40°C to +175°C
Storage Temperature	–55°C to +150°C

† Notice: Stresses beyond those listed below may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

Electrical Specifications: Grade 1: $T_{amb} = -40^{\circ}C$ to +125°C, Grade 0: $T_{amb} = -40^{\circ}C$ to +150°C, $V_{VCC} = 4.5V$ to 5.5V; $V_{VIO} = 2.8V$ to 5.5V; $R_L = 60\Omega$, $C_L = 100$ pF, unless otherwise specified. All voltages are defined in relation to ground; positive currents flow into the IC.

ground; positive currents flow	into the IC.			1		
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Supply, Pin VCC						
Supply Voltage	V _{VCC}	4.5	_	5.5	V	
Supply Current in Silent Mode	I _{VCC_sil}	1.9	2.5	3	mA	Silent Mode, V _{TXD} = V _{VIO}
Supply Current in Normal Mode	I _{VCC_rec} I _{VCC_dom} I _{VCC_short}	2 30	50	5 70 85	mA	recessive, $V_{TXD} = V_{VIO}$ dominant, $V_{TXD} = 0V$ short between CANH and CANL ⁽¹⁾
Undervoltage Detection Threshold on Pin VCC	V _{uvd(VCC)}	2.75	—	4.5	V	
I/O Level Adapter Supply, Pi	in VIO					
Supply Voltage on Pin VIO	V _{VIO}	2.8		5.5	V	
Supply Current on Pin VIO	I _{VIO_rec}	10	80	250	μA	Normal and Silent Mode recessive, $V_{TXD} = V_{VIO}$
	I _{VIO_dom}	50	350	500	μA	Normal and Silent Mode dominant, V _{TXD} = 0V
Undervoltage Detection Threshold on Pin VIO	V _{uvd(VIO)}	1.3	_	2.7	V	
Mode Control Input, Pin S						
High-level Input Voltage	V _{IH}	$0.7 \times V_{VIO}$		V _{VIO} + 0.3	V	
Low-level Input Voltage	V _{IL}	-0.3		$0.3 \times V_{VIO}$	V	
Pull-down Resistor to GND	R _{pd}	75	125	175	kΩ	V _S = V _{VIO}
Low-level Leakage Current	ال	-2	_	+2	μA	V _S = 0V
CAN Transmit Data Input, Pi	n TXD					•
High-level Input Voltage	V _{IH}	$\begin{array}{c} 0.7 \times \\ V_{VIO} \end{array}$		V _{VIO} + 0.3	V	
Low-level Input Voltage	V _{IL}	-0.3	_	$0.3 \times V_{VIO}$	V	
Pull-up Resistor to VIO	R _{TXD}	20	35	50	kΩ	V _{TXD} = 0V
High-level Leakage Current	I _{TDX}	-2	_	+2	μA	Normal Mode, V _{TXD} = V _{VIO}
Input Capacitance	C _{TXD}	_	5	10	pF	Note 3
CAN Receive Data Output, F	Pin RXD					
High-level Output Current	I _{ОН}	-8	_	-1	mA	$V_{RXD} = V_{VIO} - 0.4V,$ $V_{VIO} = V_{VCC}$
Low-level Output Current	I _{OL}	2		12	mA	V _{RXD} = 0.4V, Bus Dominant
Bus Lines, Pins CANH and	CANL					
Single Ended Dominant Output Voltage	V _{O(dom)}	0.75	25	4.5	V	$V_{TXD} = 0V, t < t_{to(dom)TXD}$ $R_L = 50\Omega to 65\Omega$
Note 1: 100% correlation to		2.75 0.5	3.5 1.5	4.5 2.25		- pin CANH - pin CANL ⁽¹⁾

Note 1: 100% correlation tested.

2: Characterized on samples.

3: Design parameter.

ELECTRICAL CHARACTERISTICS (CONTINUED)

Electrical Specifications: Grade 1: $T_{amb} = -40^{\circ}$ C to +125°C, Grade 0: $T_{amb} = -40^{\circ}$ C to +150°C, V_{VCC} = 4.5V to 5.5V; $V_{VIO} = 2.8$ V to 5.5V; $R_L = 60\Omega$, $C_L = 100$ pF, unless otherwise specified. All voltages are defined in relation to ground; positive currents flow into the IC.

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Transmitter Voltage Symmetry	V _{Sym}	0.9	1	1.1	-	$V_{Sym} = (V_{CANH} + V_{CANL})$ $/V_{VCC}^{(3)}$
Bus Differential Output Voltage	V_{Diff}	1.5	_	3	V	V_{TXD} = 0V, t < t _{to(dom)TXD} R _L = 45 Ω to 65 Ω
		1.5	—	3.3	V	V_{TXD} = 0V, t < t _{to(dom)TXD} R _L = 70 $\Omega^{(3)}$
		1.5	—	5	V	$V_{TXD} = 0V, t < t_{to(dom)TXD}$ R _L = 2240Ω ⁽³⁾
		-50	—	+50	mV	V_{VCC} = 4.75V to 5.25V V_{TXD} = V_{VIO} , receive, no load
Recessive Output Voltage	V _{O(rec)}	2	0.5 x V _{VCC}	3	V	Normal and Silent Mode, V _{TXD} = V _{VIO} , no load
Differential Receiver Threshold Voltage (HSC)	V _{th(RX)dif}	0.5	0.7	0.9	V	Normal and Silent Mode, V _{cm(CAN)} = –27V to +27V
Differential Receiver Hysteresis Voltage (HSC)	V _{hys(RX)dif}	50	120	200	mV	Normal and Silent Mode, V _{cm(CAN)} = –27V to +27V
Dominant Output Current	I _{IO(dom)}					V_{TXD} = 0V, t < t _{to(dom)TXD} , V _{VCC} = 5V
		-75 35	_	-35 75	mA mA	- pin CANH, $V_{CANH} = -5V$ - pin CANL, $V_{CANL} = +40V$
Recessive Output Current	I _{IO(rec)}	-5	_	+5	mA	Normal and Silent Mode, $V_{TXD} = V_{VIO}$, no load, $V_{CANH} = V_{CANL} = -27V$ to +32V
Leakage Current	I _{IO(leak)}	-5	0	+5	μA	$V_{VCC} = V_{VIO} = 0V,$ $V_{CANH} = V_{CANL} = 5V$
	I _{IO(leak)}	-5	0	+5	μA	VCC = VIO connected to GND with $47k\Omega$ V _{CANH} = V _{CANL} = 5V ⁽³⁾
Input Resistance	R _i	9	15	28	kΩ	$V_{CANH} = V_{CANL} = 4V$
	R _i	9	15	28	kΩ	$\begin{array}{l} -2V \leq V_{CANH} \leq +7V, \\ -2V \leq V_{CANL} \leq +7V^{(3)} \end{array}$
Input Resistance Deviation	ΔR _i	-1	0	+1	%	Between CANH and CANL $V_{CANH} = V_{CANL} = 4V$
	ΔR _i	-1	0	+1	%	$\begin{array}{l} -2V \leq V_{CANH} \leq +7V, \\ -2V \leq V_{CANL} \leq +7V^{(3)} \end{array}$
Differential Input Resistance	R _{i(dif)}	18	30	56	kΩ	$V_{CANH} = V_{CANL} = 4V$
	R _{i(dif)}	18	30	56	kΩ	$\begin{array}{l} -2V \leq V_{CANH} \leq +7V, \\ -2V \leq V_{CANL} \leq +7V^{(3)} \end{array}$
Common-mode Input Capacitance	C _{i(cm)}	—	_	20	pF	Note 3
Differential Input Capacitance	C _{i(dif)}	—	—	10	pF	Note 3

Note 1: 100% correlation tested.

2: Characterized on samples.

3: Design parameter.

ELECTRICAL CHARACTERISTICS (CONTINUED)

Electrical Specifications: Grade 1: $T_{amb} = -40^{\circ}$ C to +125°C, Grade 0: $T_{amb} = -40^{\circ}$ C to +150°C, V_{VCC} = 4.5V to 5.5V; $V_{VIO} = 2.8$ V to 5.5V; $R_L = 60\Omega$, $C_L = 100$ pF, unless otherwise specified. All voltages are defined in relation to ground; positive currents flow into the IC.

ground; positive currents flow			_			• •••
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Differential Bus Voltage Range for RECESSIVE State Detection	V _{Diff_rec}	-3	_	+0.5	V	Normal and Silent Mode ⁽³⁾ $-27V \le V_{CANH} \le +27V$, $-27V \le V_{CANL} \le +27V$
Differential Bus Voltage Range for DOMINANT State Detection	V _{Diff_dom}	0.9		8	V	Normal and Silent Mode ⁽³⁾ -27V \leq V _{CANH} \leq +27V, -27V \leq V _{CANL} \leq +27V
Transceiver Timing, Pins CA	NH, CANL, TX	D, and R	XD, see F	igure Fig	jure 2-1 a	
Delay Time from TXD to Bus Dominant	t _{d(TXD-busdom)}	40	_	130	ns	Normal Mode ⁽²⁾
Delay Time from TXD to Bus Recessive	t _{d(TXD-busrec)}	40		130	ns	Normal Mode ⁽²⁾
Delay Time from Bus Dominant to RXD	$t_{d(busdom-RXD)}$	20	—	100	ns	Normal and Silent Mode ⁽²⁾
Delay Time from Bus Recessive to RXD	t _{d(busrec-RXD)}	20		100	ns	Normal and Silent Mode ⁽²⁾
Propagation Delay from TXD to RXD	t _{PD(TXD-RXD)}	40 40		210 200	ns ns	Normal Mode $R_L = 60\Omega$, $C_L = 100 \text{ pF}$ Rising Edge at Pin TXD Falling Edge at Pin TXD
	t _{PD(TXD-RXD)}		_	300 300	ns ns	Normal Mode $R_{L} = 150\Omega$, $C_{L} = 100 \text{ pF}$ Rising Edge at Pin TXD ⁽³⁾ Falling Edge at Pin TXD ⁽³⁾
TXD Dominant Time-out Time	t _{to(dom)} TXD	0.8	_	3	ms	V _{TXD} = 0V, Normal Mode
Delay Time for Normal Mode to Silent Mode Transition	t _{del(norm-sil)}	_	_	10	μs	Rising at Pin S ⁽³⁾
Delay Time for Silent Mode to Normal Mode Transition	t _{del(sil-norm)}	—		10	μs	Falling at Pin S ⁽³⁾
Debouncing Time for Recessive Clamping State Detection	t _{RC_det}	_	90	_	ns	V(CANH-CANL) > 900 mV RXD = HIGH ⁽³⁾
External Capacitor on the R	XD Pin CRXD ≤		H, CANL,	TXD, and	RXD, se	ee Figure 2-1 and Figure 2-3,
Recessive Bit Time on Pin RXD	t _{Bit(RXD)}	400		550	ns	Normal Mode, t _{Bit(TXD)} = 500 ns ⁽¹⁾
	t _{Bit(RXD)}	120		220	ns	Normal Mode, t _{Bit(TXD)} = 200 ns
Recessive Bit Time on the Bus	t _{Bit(Bus)}	435		530	ns	Normal Mode, t _{Bit(TXD)} = 500 ns ⁽¹⁾
	t _{Bit(Bus)}	155	-	210	ns	Normal Mode, t _{Bit(TXD)} = 200 ns
Receiver Timing Symmetry	∆t _{Rec}	-65	_	+40	ns	Normal mode, $t_{Bit(TXD)} = 500$ ns $\Delta t_{Rec} = t_{Bit(RXD)} - t_{Bit(Bus)}^{(1)}$
	Δt_{Rec}	-45		+15	ns	Normal mode, $t_{Bit(TXD)} = 200$ ns $\Delta t_{Rec} = t_{Bit(RXD)} - t_{Bit(Bus)}$

Note 1: 100% correlation tested.

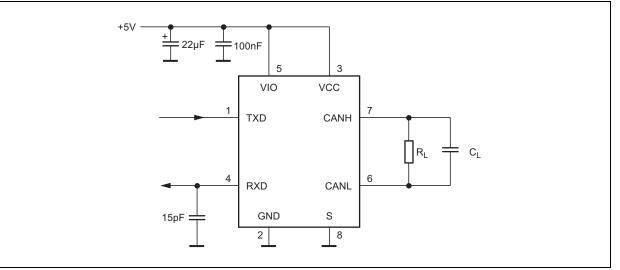
2: Characterized on samples.

3: Design parameter.

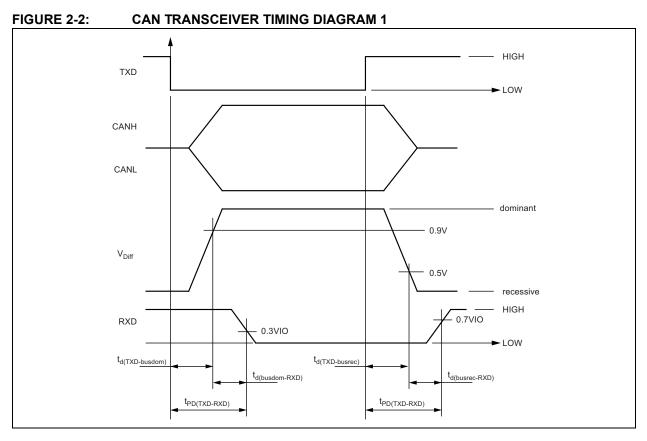
TEMPERATURE SPECIFICATIONS

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
8-pin SOIC						
Thermal Resistance Virtual Junction to Ambient	R _{thvJA}		145		K/W	
Thermal Shutdown of the Bus Drivers for ATA6564-GAQW1 (Grade 1)	T _{Jsd}	150	175	195	°C	
Thermal Shutdown of the Bus Drivers for ATA6564-GAQW0 (Grade 0)	T _{Jsd}	160	175	195	°C	
8-pin VDFN						
Thermal Resistance Virtual Junction to Heat Slug	R _{thvJC}	—	10	—	K/W	
Thermal Resistance Virtual Junction to Ambient, where Heat Slug is soldered to PCB according to JEDEC	R _{thvJA}	_	50	_	K/W	
Thermal Shutdown of the Bus Drivers for ATA6564-GBQW1 (Grade 1)	T _{Jsd}	150	175	195	°C	
Thermal Shutdown of the Bus Drivers for ATA6564-GBQW0 (Grade 0)	T _{Jsd}	160	175	195	°C	

FIGURE 2-1: TIMING TEST CIRCUIT FOR THE ATA6564 CAN TRANSCEIVER

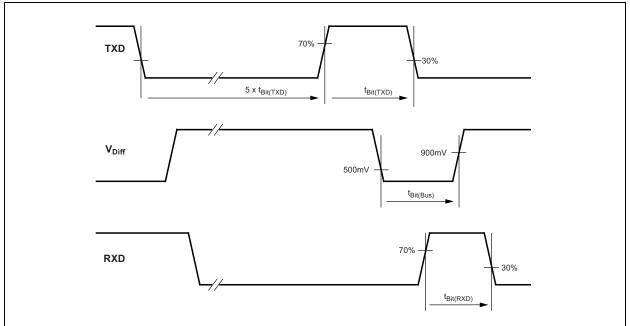


ATA6564





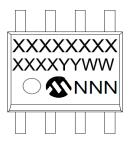
CAN TRANSCEIVER TIMING DIAGRAM 2



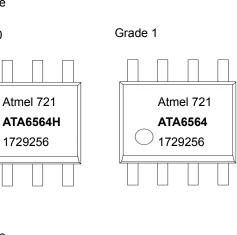
3.0 PACKAGING INFORMATION

3.1 Package Marking Information

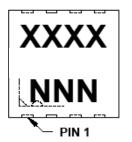
8-Lead SOIC







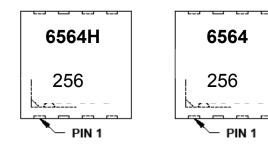
8-Lead VDFN 3 X 3 mm



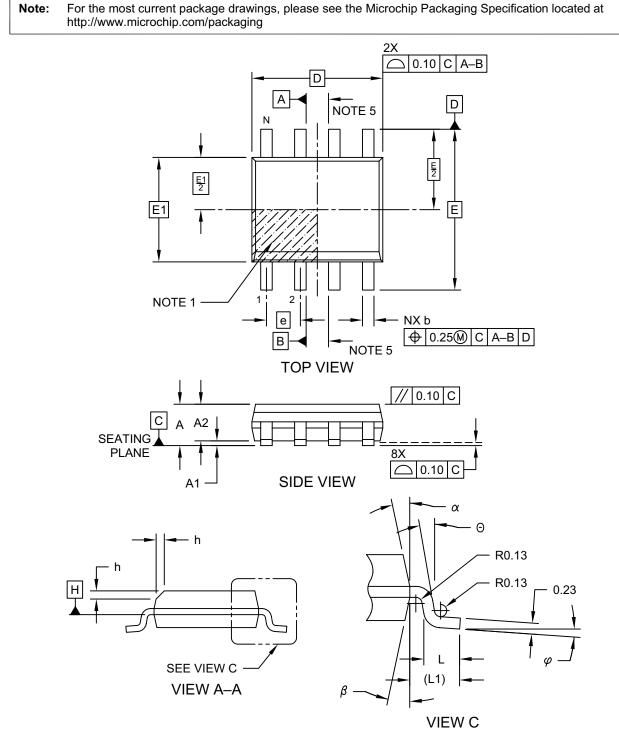


Grade 0

Grade 1



Legend:	XXX Y YY WW NNN @3 *	Customer-specific information Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code Pb-free JEDEC designator for Matte Tin (Sn) This package is Pb-free. The Pb-free JEDEC designator ((e3)) can be found on the outer packaging for this package.
	be carrie	nt the full Microchip part number cannot be marked on one line, it will d over to the next line, thus limiting the number of available s for customer-specific information.

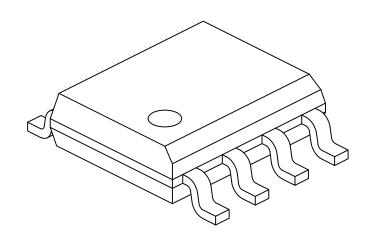


8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm (.150 In.) Body [SOIC]

Microchip Technology Drawing No. C04-057-SN Rev D Sheet 1 of 2

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm (.150 In.) Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units				
Dimensior	Limits	MIN	NOM	MAX	
Number of Pins	N		8		
Pitch	е		1.27 BSC		
Overall Height	Α	-	-	1.75	
Molded Package Thickness	A2	1.25	-	-	
Standoff §	A1	0.10	-	0.25	
Overall Width	E	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D	4.90 BSC			
Chamfer (Optional)	h	0.25	-	0.50	
Foot Length	L	0.40	-	1.27	
Footprint	L1	1.04 REF			
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.17	-	0.25	
Lead Width	b	0.31	-	0.51	
Mold Draft Angle Top	α	5°	-	15°	
Mold Draft Angle Bottom	β	5°	-	15°	

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. § Significant Characteristic

- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

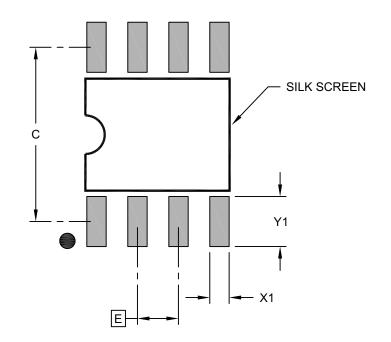
REF: Reference Dimension, usually without tolerance, for information purposes only.

5. Datums A & B to be determined at Datum H.

Microchip Technology Drawing No. C04-057-SN Rev D Sheet 2 of 2

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	MILLIMETERS			
Dimension	MIN	NOM	MAX	
Contact Pitch	E	1.27 BSC		
Contact Pad Spacing	С		5.40	
Contact Pad Width (X8)	X1			0.60
Contact Pad Length (X8)	Y1			1.55

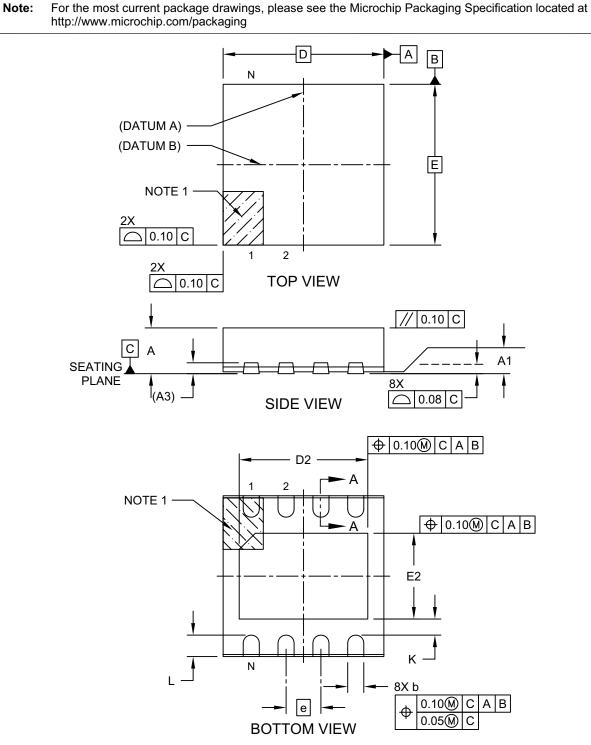
Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

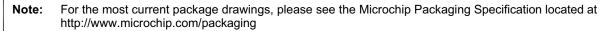
Microchip Technology Drawing C04-2057-SN Rev B

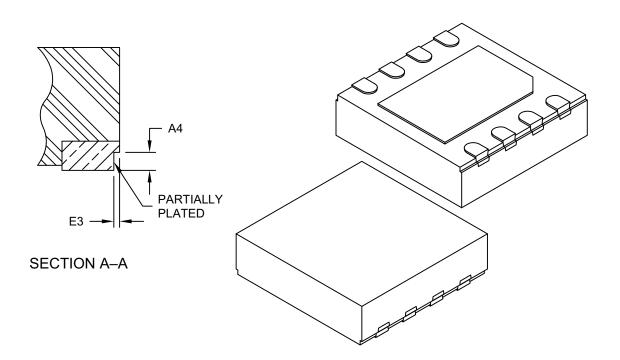
8-Lead Very Thin Plastic Dual Flat, No Lead Package (Q8B) - 3x3 mm Body [VDFN] With 2.40x1.60 mm Exposed Pad and Stepped Wettable Flanks



Microchip Technology Drawing C04-21358 Rev B Sheet 1 of 2

8-Lead Very Thin Plastic Dual Flat, No Lead Package (Q8B) - 3x3 mm Body [VDFN] With 2.40x1.60 mm Exposed Pad and Stepped Wettable Flanks





	Units					
Dimension	Limits	MIN	NOM	MAX		
Number of Terminals	N		8			
Pitch	е		0.65 BSC			
Overall Height	Α	0.80	0.85	0.90		
Standoff	A1	0.00	0.03	0.05		
Terminal Thickness	A3		0.203 REF			
Overall Length	D	3.00 BSC				
Exposed Pad Length	D2	2.30	2.40	2.50		
Overall Width	E		3.00 BSC			
Exposed Pad Width	E2	1.50	1.60	1.70		
Terminal Width	b	0.25	0.30	0.35		
Terminal Length	L	0.35	0.40	0.45		
Terminal-to-Exposed-Pad	K	0.20	-	-		
Wettable Flank Step Cut Depth	A4	0.10	0.13	0.15		
Wettable Flank Step Cut Width	E3	-	-	0.04		

Notes:

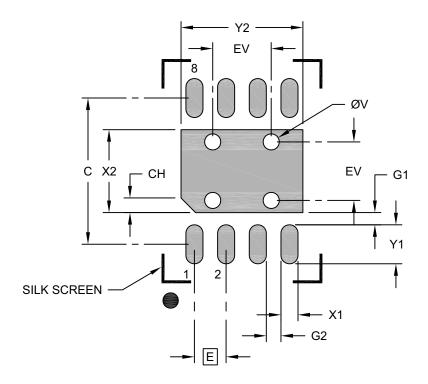
- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package is saw singulated
- 3. Dimensioning and tolerancing per ASME Y14.5M
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-21358 Rev B Sheet 2 of 2

8-Lead Very Thin Plastic Dual Flat, No Lead Package (Q8B) - 3x3 mm Body [VDFN] With 2.40x1.60 mm Exposed Pad and Stepped Wettable Flanks

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	Units			MILLIMETERS					
Dimension	Dimension Limits								
Contact Pitch	Contact Pitch E								
Optional Center Pad Width	X2			1.70					
Optional Center Pad Length	Y2			2.50					
Contact Pad Spacing	С		3.00						
Contact Pad Width (X8)	X1			0.35					
Contact Pad Length (X8)	Y1			0.80					
Contact Pad to Center Pad (X8)	G1	0.20							
Contact Pad to Contact Pad (X6)	G2	0.20							
Pin 1 Index Chamfer	СН	0.20							
Thermal Via Diameter	V		0.33						
Thermal Via Pitch	EV		1.20						

Notes:

- 1. Dimensioning and tolerancing per ASME Y14.5M
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.
- 2. For best soldering results, thermal vias, if used, should be filled or tented to avoid solder loss during reflow process

Microchip Technology Drawing C04-23358 Rev B

APPENDIX A: REVISION HISTORY

Revision B (July 2017)

The following is the list of modifications:

- 1. Added the new device ATA6564-GBQW0 and updated the related information across the document.
- 2. Updated Table 0-1.
- 3. Corrected Section "Electrical Characteristics".
- 4. Updated Section "Temperature Specifications".
- 5. Updated the VDFN8 package drawing and added a Grade 0 package example to Section 3.1, Package Marking Information.
- 6. Added a ATA6564-GBQW0 example to Section "Product Identification System".
- 7. Various typographical edits.

Revision A (June 2017)

• Original Release of this Document.

ATA6564

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

	v		·v•(1)	Y		v		Exa	ampl	es:			
PART NO. X Device Pac		Гаре	XI ⁽¹⁾ and Reel tion	X Package classifica		X Temperatu Range	ire	a)	ATA	6564	4-GAQW0:	Ta a	TA6564, 8-Lead SOIC, ape and Reel, Package ccording to RoHS, emperature Grade 0
Device: Package:	ATA GA	.6564:		de CAN FD		iver with Silent		b)	ATA	6564	4-GBQW0:	Ta a	TA6564, 8-Lead VDFN, ape and Reel, Package ccording to RoHS, emperature Grade 0
Tape and Reel Option:	GB Q	=	8-Lead		e and Ree	el		c)	ATA	6564	4-GAQW1:	Ta a	TA6564, 8-Lead SOIC, ape and Reel, Package ccording to RoHS, emperature Grade 1
Package directives classification:	w	=	Package	according to	RoHS ⁽²⁾			d)	ATA	6564	4-GBQW1:	Ta a	TA6564, 8-Lead VDFN, ape and Reel, Package ccording to RoHS, emperature Grade 1
Temperature Range:	01	=		ure Grade 0 ure Grade 1				Ν	Note		catalog pridentifier is not printed your Micro availability w RoHS con value of 0. and Chlorin ppm) total any home concentratio	art nu used for on the or ochip s with the npliant, 09% (s ie (CI) Bromin ogeneo on valu	entifier only appears in th umber description. Th or ordering purposes and device package. Check wi Sales Office for packag e Tape and Reel option. Maximum concentratio 200 ppm) for Bromine (E and less than 0.15% (150 e (Br) and Chlorine (Cl) bus material. Maximu any homogeneous materia

ATA6564

NOTES:

Note the following details of the code protection feature on Microchip devices:

- · Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
- Neither Microchip nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as "unbreakable."

Code protection is constantly evolving. We at Microchip are committed to continuously improving the code protection features of our products. Attempts to break Microchip's code protection feature may be a violation of the Digital Millennium Copyright Act. If such acts allow unauthorized access to your software or other copyrighted work, you may have a right to sue for relief under that Act.

Information contained in this publication regarding device applications and the like is provided only for your convenience and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. MICROCHIP MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, MERCHANTABILITY OR FITNESS FOR PURPOSE. Microchip disclaims all liability arising from this information and its use. Use of Microchip devices in life support and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend, indemnify and hold harmless Microchip from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microchip intellectual property rights unless otherwise stated.

Microchip received ISO/TS-16949:2009 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.

QUALITY MANAGEMENT SYSTEM CERTIFIED BY DNV = ISO/TS 16949=

Trademarks

The Microchip name and logo, the Microchip logo, AnyRate, AVR, AVR logo, AVR Freaks, BeaconThings, BitCloud, CryptoMemory, CryptoRF, dsPIC, FlashFlex, flexPWR, Heldo, JukeBlox, KEELoa, KEELoa logo, Kleer, LANCheck, LINK MD, maXStylus, maXTouch, MediaLB, megaAVR, MOST, MOST logo, MPLAB, OptoLyzer, PIC, picoPower, PICSTART, PIC32 logo, Prochip Designer, QTouch, RightTouch, SAM-BA, SpyNIC, SST, SST Logo, SuperFlash, tinyAVR, UNI/O, and XMEGA are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

ClockWorks, The Embedded Control Solutions Company, EtherSynch, Hyper Speed Control, HyperLight Load, IntelliMOS, mTouch, Precision Edge, and Quiet-Wire are registered trademarks of Microchip Technology Incorporated in the U.S.A.

Adjacent Key Suppression, AKS, Analog-for-the-Digital Age, Any Capacitor, Anyln, AnyOut, BodyCom, chipKIT, chipKIT logo, CodeGuard, CryptoAuthentication, CryptoCompanion, CryptoController, dsPICDEM, dsPICDEM.net, Dynamic Average Matching, DAM, ECAN, EtherGREEN, In-Circuit Serial Programming, ICSP, Inter-Chip Connectivity, JitterBlocker, KleerNet, KleerNet logo, Mindi, MiWi, motorBench, MPASM, MPF, MPLAB Certified logo, MPLIB, MPLINK, MultiTRAK, NetDetach, Omniscient Code Generation, PICDEM, PICDEM.net, PICkit, PICtail, PureSilicon, QMatrix, RightTouch logo, REAL ICE, Ripple Blocker, SAM-ICE, Serial Quad I/O, SMART-I.S., SQI, SuperSwitcher, SuperSwitcher II, Total Endurance, TSHARC, USBCheck, VariSense, ViewSpan, WiperLock, Wireless DNA, and ZENA are trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

SQTP is a service mark of Microchip Technology Incorporated in the U.S.A.

Silicon Storage Technology is a registered trademark of Microchip Technology Inc. in other countries.

GestIC is a registered trademark of Microchip Technology Germany II GmbH & Co. KG, a subsidiary of Microchip Technology Inc., in other countries.

All other trademarks mentioned herein are property of their respective companies.

© 2017, Microchip Technology Incorporated, All Rights Reserved. ISBN: 978-1-5224-1976-1



Worldwide Sales and Service

AMERICAS

Corporate Office 2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: http://www.microchip.com/ support

Web Address: www.microchip.com

Atlanta Duluth, GA Tel: 678-957-9614 Fax: 678-957-1455

Austin, TX Tel: 512-257-3370

Boston Westborough, MA Tel: 774-760-0087 Fax: 774-760-0088

Chicago Itasca, IL Tel: 630-285-0071 Fax: 630-285-0075

Dallas Addison, TX Tel: 972-818-7423 Fax: 972-818-2924

Detroit Novi, MI Tel: 248-848-4000

Houston, TX Tel: 281-894-5983

Indianapolis Noblesville, IN Tel: 317-773-8323 Fax: 317-773-5453 Tel: 317-536-2380

Los Angeles Mission Viejo, CA Tel: 949-462-9523 Fax: 949-462-9608 Tel: 951-273-7800

Raleigh, NC Tel: 919-844-7510

New York, NY Tel: 631-435-6000

San Jose, CA Tel: 408-735-9110 Tel: 408-436-4270

Canada - Toronto Tel: 905-695-1980 Fax: 905-695-2078

ASIA/PACIFIC

Asia Pacific Office Suites 3707-14, 37th Floor Tower 6, The Gateway

Harbour City, Kowloon Hong Kong Tel: 852-2943-5100 Fax: 852-2401-3431

Australia - Sydney Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

China - Beijing Tel: 86-10-8569-7000 Fax: 86-10-8528-2104

China - Chengdu Tel: 86-28-8665-5511 Fax: 86-28-8665-7889

China - Chongqing Tel: 86-23-8980-9588 Fax: 86-23-8980-9500

China - Dongguan Tel: 86-769-8702-9880

China - Guangzhou Tel: 86-20-8755-8029

China - Hangzhou Tel: 86-571-8792-8115 Fax: 86-571-8792-8116

China - Hong Kong SAR Tel: 852-2943-5100

China - Nanjing Tel: 86-25-8473-2460 Fax: 86-25-8473-2470

Fax: 852-2401-3431

China - Qingdao Tel: 86-532-8502-7355 Fax: 86-532-8502-7205

China - Shanghai Tel: 86-21-3326-8000 Fax: 86-21-3326-8021

China - Shenyang Tel: 86-24-2334-2829 Fax: 86-24-2334-2393

China - Shenzhen Tel: 86-755-8864-2200 Fax: 86-755-8203-1760

China - Wuhan Tel: 86-27-5980-5300 Fax: 86-27-5980-5118

China - Xian Tel: 86-29-8833-7252 Fax: 86-29-8833-7256 ASIA/PACIFIC

China - Xiamen Tel: 86-592-2388138 Fax: 86-592-2388130

China - Zhuhai Tel: 86-756-3210040 Fax: 86-756-3210049

India - Bangalore Tel: 91-80-3090-4444 Fax: 91-80-3090-4123

India - New Delhi Tel: 91-11-4160-8631 Fax: 91-11-4160-8632

India - Pune Tel: 91-20-3019-1500

Japan - Osaka Tel: 81-6-6152-7160 Fax: 81-6-6152-9310

Japan - Tokyo Tel: 81-3-6880- 3770 Fax: 81-3-6880-3771

Korea - Daegu Tel: 82-53-744-4301 Fax: 82-53-744-4302

Korea - Seoul Tel: 82-2-554-7200 Fax: 82-2-558-5932 or 82-2-558-5934

Malaysia - Kuala Lumpur Tel: 60-3-6201-9857 Fax: 60-3-6201-9859

Malaysia - Penang Tel: 60-4-227-8870 Fax: 60-4-227-4068

Philippines - Manila Tel: 63-2-634-9065 Fax: 63-2-634-9069

Singapore Tel: 65-6334-8870 Fax: 65-6334-8850

Taiwan - Hsin Chu Tel: 886-3-5778-366 Fax: 886-3-5770-955

Taiwan - Kaohsiung Tel: 886-7-213-7830

Taiwan - Taipei Tel: 886-2-2508-8600 Fax: 886-2-2508-0102

Thailand - Bangkok Tel: 66-2-694-1351 Fax: 66-2-694-1350

EUROPE

Austria - Wels Tel: 43-7242-2244-39 Fax: 43-7242-2244-393

Denmark - Copenhagen Tel: 45-4450-2828 Fax: 45-4485-2829

Finland - Espoo Tel: 358-9-4520-820

France - Paris Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

France - Saint Cloud Tel: 33-1-30-60-70-00

Germany - Garching Tel: 49-8931-9700 **Germany - Haan** Tel: 49-2129-3766400

Germany - Heilbronn Tel: 49-7131-67-3636

Germany - Karlsruhe Tel: 49-721-625370

Germany - Munich Tel: 49-89-627-144-0 Fax: 49-89-627-144-44

Germany - Rosenheim Tel: 49-8031-354-560

Israel - Ra'anana Tel: 972-9-744-7705

Italy - Milan Tel: 39-0331-742611 Fax: 39-0331-466781

Italy - Padova Tel: 39-049-7625286

Netherlands - Drunen Tel: 31-416-690399 Fax: 31-416-690340

Norway - Trondheim Tel: 47-7289-7561

Poland - Warsaw Tel: 48-22-3325737

Romania - Bucharest Tel: 40-21-407-87-50

Spain - Madrid Tel: 34-91-708-08-90 Fax: 34-91-708-08-91

Sweden - Gothenberg Tel: 46-31-704-60-40

Sweden - Stockholm Tel: 46-8-5090-4654

UK - Wokingham Tel: 44-118-921-5800 Fax: 44-118-921-5820